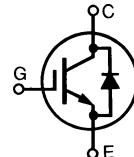


IGBT with Diode ISOPLUS 247™ (Electrically Isolated Backside)

Short Circuit SOA Capability

IXSR 40N60BD1

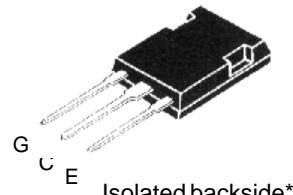
V_{CES} = 600 V
 I_{C25} = 70 A
 $V_{CE(sat)}$ = 2.2 V
 $t_{fi(ty)}$ = 120 ns



Symbol	Test Conditions	Maximum Ratings		
V_{CES}	$T_J = 25^\circ\text{C}$ to 150°C	600	V	
V_{CGR}	$T_J = 25^\circ\text{C}$ to 150°C ; $R_{GE} = 1 \text{ M}\Omega$	600	V	
V_{GES}	Continuous	± 20	V	
V_{GEM}	Transient	± 30	V	
I_{C25}	$T_c = 25^\circ\text{C}$	70	A	
I_{C90}	$T_c = 90^\circ\text{C}$	40	A	
I_{CM}	$T_c = 25^\circ\text{C}$, 1 ms	150	A	
SSOA (RBSOA)	$V_{GE} = 15 \text{ V}$, $T_{VJ} = 125^\circ\text{C}$, $R_G = 22 \Omega$ Clamped inductive load, $L = 30 \mu\text{H}$	$I_{CM} = 80$ @ 0.8 V_{CES}	A	
t_{sc} (SCSOA)	$V_{GE} = 15 \text{ V}$, $V_{CE} = 360 \text{ V}$, $T_J = 125^\circ\text{C}$ $R_G = 22 \Omega$, non repetitive	10	μs	
P_c	$T_c = 25^\circ\text{C}$	170	W	
T_J		-55 ... +150	$^\circ\text{C}$	
T_{JM}		150	$^\circ\text{C}$	
T_{stg}		-55 ... +150	$^\circ\text{C}$	
V_{ISOL}	50/60 Hz, RMS t = 1 min leads-to housing	2500	V~	
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	$^\circ\text{C}$	
Weight		5	g	

ISOPLUS 247™

E153432



G = Gate, C = Collector,
E = Emitter

* Patent pending

Features

- DCB Isolated mounting tab
- Meets TO-247AD package Outline
- High current handling capability
- Latest generation HDMOS™ process
- MOS Gate turn-on
 - drive simplicity

Applications

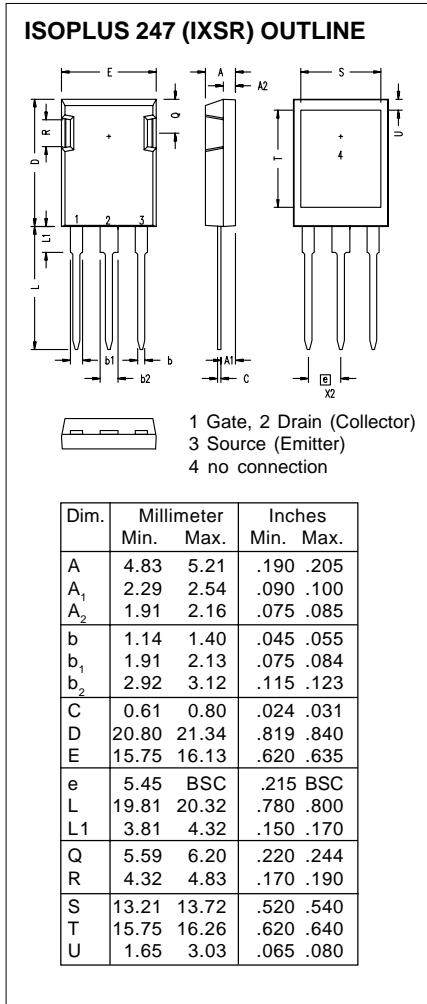
- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies
- AC motor speed control
- DC servo and robot drives
- DC choppers

Advantages

- Easy assembly
- High power density
- Very fast switching speeds for high frequency applications

Symbol	Test Conditions	Characteristic Values		
		($T_J = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.
BV_{CES}	$I_c = 1 \text{ mA}$, $V_{GE} = 0 \text{ V}$	600		V
$V_{GE(th)}$	$I_c = 4 \text{ mA}$, $V_{CE} = V_{GE}$	4	7	V
I_{CES}	$V_{CE} = 0.8 \cdot V_{CES}$ $V_{GE} = 0 \text{ V}$	$T_J = 25^\circ\text{C}$ $T_J = 150^\circ\text{C}$	650 5	μA mA
I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$		± 100	nA
$V_{CE(sat)}$	$I_c = I_T$, $V_{GE} = 15 \text{ V}$		2.2	V

Symbol	Test Conditions	Characteristic Values		
		($T_j = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.
g_{fs}	$I_c = I_T; V_{CE} = 10 \text{ V},$ Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $\leq 2\%$	16	23	S
C_{iss} C_{oss} C_{rss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	3700		pF
		440		pF
		60		pF
Q_g Q_{ge} Q_{gc}	$I_c = I_T, V_{GE} = 15 \text{ V}, V_{CE} = 0.5 V_{CES}$	190		nC
		45		nC
		88		nC
$t_{d(on)}$ t_{ri} $t_{d(off)}$ t_{fi} E_{off}	Inductive load, $T_j = 25^\circ\text{C}$ $I_c = I_T, V_{GE} = 15 \text{ V}, L = 100 \mu\text{H},$ $V_{CE} = 0.8 V_{CES}, R_G = 2.7 \Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_j or increased R_G	50		ns
		50		ns
		110	200	ns
		120	200	ns
		1.8	2.6	mJ
		50		ns
$t_{d(on)}$ t_{ri} E_{on} $t_{d(off)}$ t_{fi} E_{off}	Inductive load, $T_j = 125^\circ\text{C}$ $I_c = I_T, V_{GE} = 15 \text{ V}, L = 100 \mu\text{H}$ $V_{CE} = 0.8 V_{CES}, R_G = 2.7 \Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_j or increased R_G	50		ns
		50		ns
		2.2		mJ
		190		ns
		180		ns
		2.6		mJ
R_{thJC}			0.73	K/W
R_{thCK}		0.15		K/W



Symbol	Test Conditions	Characteristic Values		
		($T_j = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.
V_F	$I_F = I_T, V_{GE} = 0 \text{ V},$ Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2\%$		1.8	V
I_{RM} t_{rr}	$I_F = I_T, V_{GE} = 0 \text{ V}, -di_F/dt = 100 \text{ A}/\mu\text{s}$ $V_R = 100 \text{ V}$ $I_F = 1 \text{ A}; -di/dt = 200 \text{ A}/\mu\text{s}; V_R = 30 \text{ V}$	2	2.5	A
		35		ns
R_{thJC}			1.15	K/W

Note: 1. $I_T = 40\text{A}$